	- UE 2's	2004					Sheet	1	of <u>1</u>	
Form PTO-1449 FORM PTO-1449 US Dept. of Commerce (REV. 8-83) PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT				ATTY DOCKET NO. 119498				APPLICATION NO. 10/826,354		
(Use several sheets if necessary)				APPLICANT Hiromi OTOMA EXAM				INER: CHUC TRA		
				FILING DATE April 19, 2004			GROUP 282/			
		U.S. 1	PATE	NT DOCU	IMENTS					
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TC	1.	JP A 2002-185079 w/abstract & transl.	6/28	/2002	JAPAN					
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		OTHER DOCUMENTS (Inc.	luding	g Author,	ritle, Date, Pertinent Pag	ges, etc.)				
	2.	Kenichi IGA; "Surface Emitting Laser"; IEICE Transactions C-1, Vol. J81-C-1, No. 9; September 1998; pp 483-493								
TC	·									
	4.	Nobuaki UEKI et al.; "Single-Transverse-Mode 3.4-mW Emission of Oxide-confined 780-nm Vcsel's"; IEEE Photonics Technology Letters; Vol. 11, No. 12; December 1999; pp 1539-1541								
TC	5. Jun SAKURAI et al.; "10 Gb/s Surface Emission Semiconductor Laser"; Electronic Materials, Vol. 41, No. 11; No. 2002; pp 49-52									
TO	6.	M. Grabherr et al.; "Efficient Single-Mode Oxide-Confined GaAs VCSEL's Emitting in the 850-nm Wavelength Regime"; IEEE Photonics Technology Letters; Vol. 9, No. 10,; October 1997; pp 1304-1306								

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Aaron et al.; "Aperture Placement Effects in Oxide-Defined Vertical-Cavity Surface-Emitting Lasers"; IEEE Photonics Technology Letters; Vol. 10, No. 10; October 1998; pp-1362-1364

DATE CONSIDERED

Date: July 29, 2004

EXAMINER